TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOS)

2SK2466

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• 4-V gate drive

• Low drain—source ON resistance : $RDS (ON) = 34 \text{ m}\Omega \text{ (typ.)}$ • High forward transfer admittance : $|Y_{fs}| = 30 \text{ S (typ.)}$ • Low leakage current : $IDSS = 100 \text{ }\mu\text{A (max)} \text{ (VDS} = 100 \text{ V)}$

• Enhancement mode : $V_{th} = 0.8 \sim 2.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteri	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	100	V	
Drain-gate voltage (R	_{GS} = 20 kΩ)	V_{DGR}	100	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	ID	30	Α	
	Pulse (Note 1)	I_{DP}	120		
Drain power dissipatio	n (Tc = 25°C)	P_{D}	40	W	
Single pulse avalanche	e energy (Note 2)	E _{AS}	293	mJ	
Avalanche current		I _{AR}	30	Α	
Repetitive avalanche	energy (Note 3)	E _{AR}	4	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature r	ange	T _{stg}	-55~150	°C	

Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	3.125	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	62.5	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: V_{DD} = 25 V, T_{ch} = 25°C (initial), L = 525 μ H, R_{G} = 25 Ω , I_{AR} = 30 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



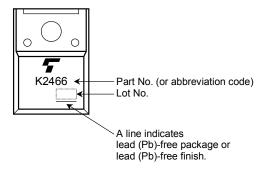
Electrical Characteristics (Ta = 25°C)

Charao	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 100 V, V _{GS} = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	V (BR) DSS	I _D = 10 mA, V _{GS} = 0 V	100	_	_	٧
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	8.0	_	2.0	V
Drain-source ON resistance		R _{DS (ON)}	V _{GS} = 4 V, I _D = 15 A	_	40	70	mΩ
			V _{GS} = 10 V, I _D = 15 A	_	34	46	
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 15 A	13	30	_	S
Input capacitano	ce	C _{iss}		_	3250	_	
Reverse transfe	r capacitance	C _{rss}	V _{rss} V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	230	_	pF
Output capacitance		C _{oss}		_	520	_	
Switching time	Rise time	t _r	$V_{GS} = 15 \text{ A} \\ V_{GS} = 15 \text{ A} \\ V_{Out} =$	_	33	_	ns
	Turn-on time	t _{on}		_	60	_	
	Fall time	t _f		_	95	_	
	Turn-off time	t _{off}	Duty \leq 1%, $t_{\rm W}$ = 10 μ s	_	230	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	68	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx 80 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 30 \text{ A}$		46	_	nC
Gate-drain ("miller") charge		Q _{gd}		_	22	_	

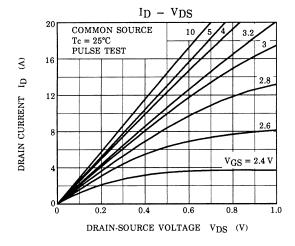
Source-Drain Ratings and Characteristics (Ta = 25°C)

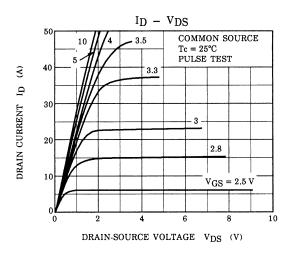
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	30	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	120	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 30 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 30 A, V _{GS} = 0 V	1	120	_	ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 50 A / μs		280	_	μC

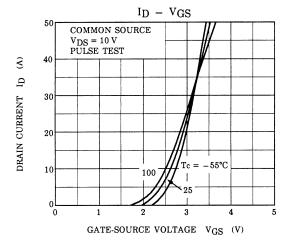
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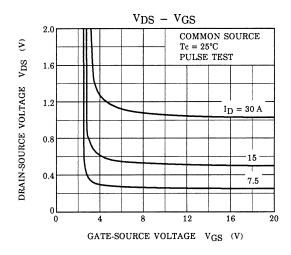


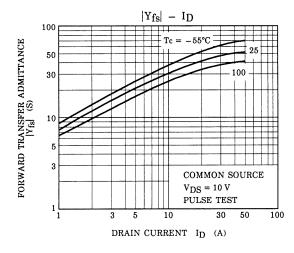
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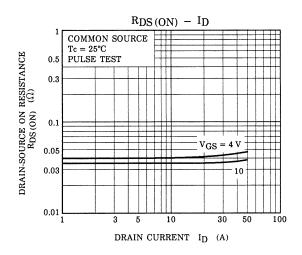


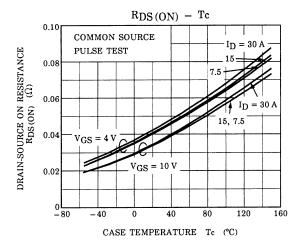


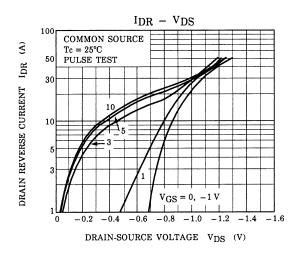


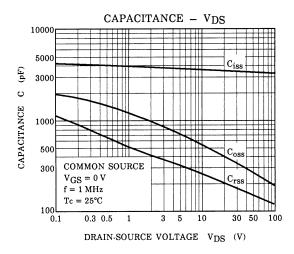


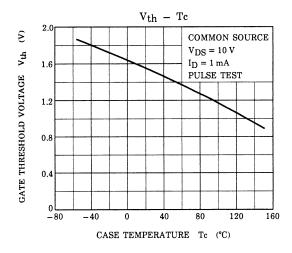


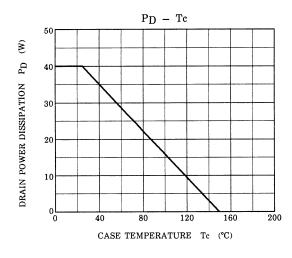


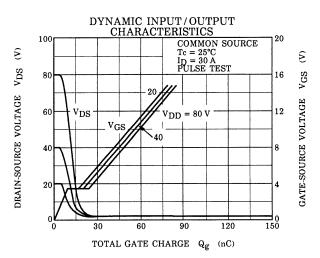




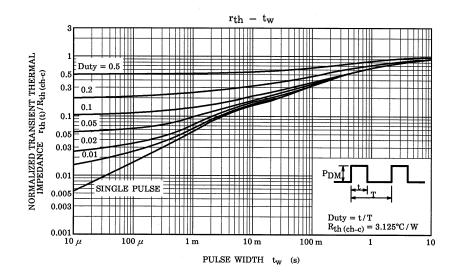


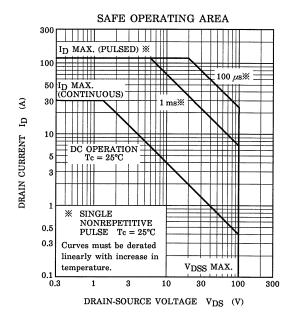


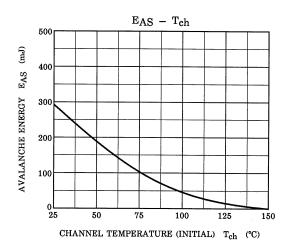


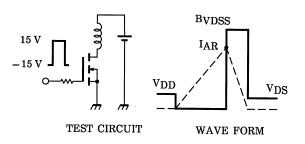


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$$R_G$$
 = 25 Ω
 V_{DD} = 25 V, L = 525 μ H

$$EAS = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right)$$

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Handbook" etc..

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